

# 200V PNP LOW $V_{\text{CE(sat)}}$ TRANSISTOR IN SOT-89

#### **Features**

- BV<sub>CEO</sub> > -200V
- BV<sub>ECO</sub> > -2V
- Continuous current I<sub>C(cont)</sub> = 2A
- V<sub>CE(sat</sub> < -160mV @ -1A</li>
- R<sub>CE(sat)</sub>=130mΩ
- P<sub>D</sub> = 2.4W
- 2 Amps continuous current
- Up to 5 Amps peak current
- Very low saturation voltage
- Enhanced switching performance

#### **Applications**

DC-DC Convertors

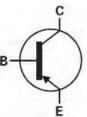
#### **Mechanical Data**

- Case: SOT-89
- UL Flammability Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish
- Weight: 0.052 grams (approximate)

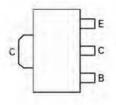




Top View



Device symbol

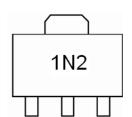


Pin Configuration

### **Ordering Information**

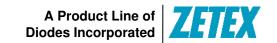
Product	Product Marking		Tape width (mm)	Quantity per reel	
ZXTP03200BZTA	1N2	7	12	1000	

# **Marking Information**



1N2 = Product type Marking Code





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# **Maximum Ratings** $@T_A = 25^{\circ}C$ unless otherwise specified

Characteristic	Symbol	Value	Unit	
Collector-Base Voltage	$V_{CBO}$	-220	V	
Collector-Emitter Voltage	$V_{CEO}$	-200	V	
Emitter-Base Voltage	V <sub>EBO</sub>	-7	V	
Continuous Collector Current (Note a)	Ic	-2	Α	
Base Current	Ι <sub>Β</sub>	-1	Α	
Peak Pulse Current	I <sub>CM</sub>	-5	Α	

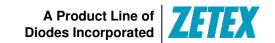
# **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation at T <sub>A</sub> = 25°C (Note a) Linear derating factor	P <sub>D</sub>	1.1 8.8	W mW /°C
Power Dissipation at $T_A = 25^{\circ}C$ (Note b) Linear derating factor	P <sub>D</sub>	1.8 14.4	W mW /°C
Power Dissipation at $T_A = 25^{\circ}C$ (Note c) Linear derating factor	$P_{D}$	2.4 19.2	W mW /°C
Power Dissipation at T <sub>A</sub> = 25°C (Note d) Linear derating factor	$P_{D}$	4.46 35.7	W mW /°C
Power Dissipation at T <sub>A</sub> = 25°C (Note e) Linear derating factor	$P_{D}$	38.7 309.6	W mW /°C
Junction to Ambient (Note a)	$R_{ hetaJA}$	117	°C/W
Junction to Ambient (Note b)	$R_{ hetaJA}$	68	°C/W
Junction to Ambient (Note c)	$R_{ hetaJA}$	51	°C/W
Junction to Ambient (Note d)	$R_{ hetaJA}$	28	°C/W
Junction to Lead (Note e)	$R_{ hetaJL}$	3.23	°C/W
Operating and Storage Temperature Range	$T_{J}, T_{STG}$	-55 to +150	°C

- a. For a device surface mounted on 15mm X 15mm X 1.6mm FR4 PCB with high coverage of single sided 1 oz copper, in still air conditions
  b. Mounted on 25mm X 25mm X 1.6mm FR4 PCB with high coverage of single sided 1 oz copper, in still air conditions.
  c. Mounted on 25mm X 25mm X 1.6mm FR4 PCB with high coverage of single sided 2 oz copper, in still air conditions.

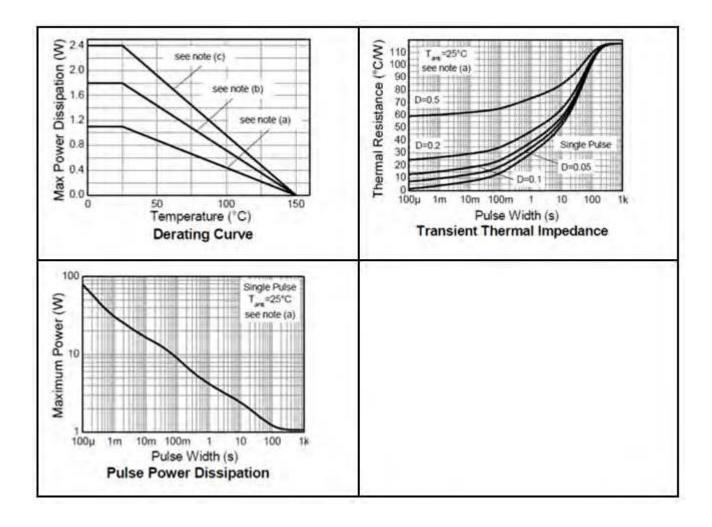
- d. As (c) above measured at t<5 seconds
- e. Junction to lead from collector Tab. Typical





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# **Thermal Characteristics and Derating information**







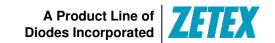
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# Electrical Characteristics @T<sub>A</sub> = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
Collector-Base Breakdown Voltage	V <sub>(BR)CBO</sub>	-220	-245		V	$I_{C} = -100 \mu A$
Collector-Emitter Breakdown Voltage	$V_{(BR)CER}$	-220	-245		V	$I_C = -1\mu A$ , $R_{BE} \le 1k\Omega$
Collector-Emitter Breakdown Voltage (Note f)	$V_{(BR)CEO}$	-220	-225		V	I <sub>C</sub> = -10mA
Emitter-Base Breakdown Voltage	$V_{(BR)EBO}$	-7	-8.4		V	$I_E = -100 \mu A$
Collector-Base Cutoff Current	I <sub>CBO</sub>		<1	-50 -0.5	nA μA	$V_{CB} = -200V$ $V_{CB} = -200V$ , $T_{amb} = 100$ °C
Emitter Cutoff Current	I <sub>EBO</sub>		<1	-10	. nA	V <sub>EB</sub> = -6V
Static Forward Current Transfer Ratio (Note f)	h <sub>FE</sub>	100 100 20	195 179 50 5	300		I <sub>C</sub> = -10mA, V <sub>CE</sub> = -5V I <sub>C</sub> = -1A, V <sub>CE</sub> = -5V I <sub>C</sub> = -2A, V <sub>CE</sub> = -5V I <sub>C</sub> = -5A, V <sub>CE</sub> = -5V
Collector-Emitter Saturation Voltage (Note f)	$V_{CE(SAT)}$		-37 -120 -130 -160	-50 -155 -160 -260	mV mV mV	I <sub>C</sub> = -100mA, I <sub>B</sub> = -10mA I <sub>C</sub> = -500mA, I <sub>B</sub> = -25mA I <sub>C</sub> = -1A, I <sub>B</sub> = -100mA I <sub>C</sub> = -2A, I <sub>B</sub> = -400mA
Base-Emitter Saturation Voltage (Note f)	V <sub>BE(sat)</sub>		-940	-1100	mV	I <sub>C</sub> = -2A, I <sub>B</sub> = -400mV
Base-Emitter Turn-On Voltage (Note f)	V <sub>BE(ON)</sub>		-840	-1000	mV	$I_C = -2A, V_{CE} = -5V$
Output Capacitance (Note f)	$C_{obo}$		31		pF	V <sub>CB</sub> = -10V. f = 1MHz
Transition Frequency	f <sub>T</sub>		105		MHz	$V_{CE} = -10V, I_{C} = -100mA$ f = 50MHz
Delay Time	t <sub>d</sub>		21		ns	
Rise Time	t <sub>r</sub>		18		ns	$V_{CC} = -50V, I_{C} = -1A$
Storage Time	Ts		680		ns	$I_{B1} = -I_{B2} = -100 \text{mA}$
Fall Time	T <sub>f</sub>		75		ns	

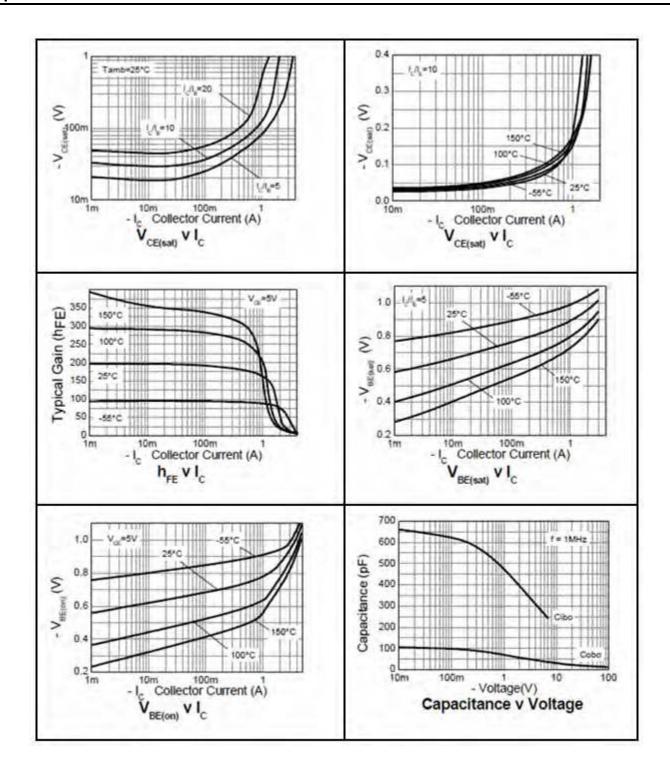
Notes: f. Measured under pulsed conditions. Pulse width = 300  $\mu$ s. Duty cycle  $\leq$  2%



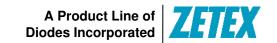


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## **Typical Characteristics**

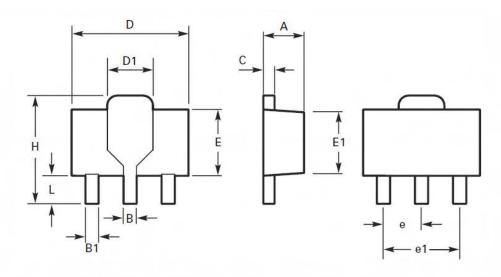






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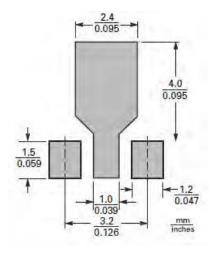
# **Package Outline Dimensions**



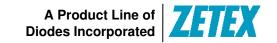
DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	1.40	1.60	0.550	0.630	E	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
C	0.35	0.44	0.014	0.017	e1	3.00 BSC		0.118 BSC	
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.52	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

# **Suggested Pad Layout**







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